Study of CR-39 SSNDs irradiated with different types of radiation by FTIR spectroscopy and α-range determination

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To cite this article:

Abstract: Studies of CR-39 irradiated with γ-rays, X-rays and alpha particles by FTIR spectroscopy are presented. In this work we make a comparison between the effect of many types of radiation on the sensitivity of CR-39 detector by using the FTIR spectrometer. It was found that investigated CR-39 is so sensitive for all types of radiation used that was used as a dosimeter for these types of radiation. The determination of alpha particles range in CR-39 plastic recorder is an important parameter in the field of charged particle identification using Solid State Nuclear Track Detectors. In this work the optical density of the detector was calculated and then it is used to determine α-range. An over-etched track profile method and a theoretical method derived by Almasi are compared. A good agreement between the three methods used in α-range determination was found.

Keywords: CR-39, FTIR- Spectroscopy

1. Introduction

Characteristics of solid state nuclear track detectors were studied by many authors. It is well known that, track size, bulk etch rate and track etch rate are affected by exposing detectors to several types of radiations such as, X-ray, γ-rays, UV and alpha particles [1, 2, 3, 4, 5, 6]. The two main changes noticed in polymers are [7]:

1) Chain cross linking resulting in an increases of molecular weight because of a large number of free radicals produced in polymer.

2) Chain scission resulting in a decrease of molecular weight and substantislly changing in polymer material properties.

In addition to these changes, small molecules such as Co, Co2 and H2 may be produced resulting from bond scission.

In this study FTIR spectroscopy technique was used to analyze the effect of radiation on CR-39 plastic detector which is used in several studies. (9, 11, 13, 14) FTIR-spectrometers analyze light by measuring the fourier transformed intensity of a spectrum with the use of a Michelson interferometer or modified versions of it. The interferogram is obtained by a scanning mirror and the spectrum obtained by a Fourier Transformation.

The main advantage of this technique arises from the fact that the photo detector receives light from all spectral elements simultaneously at each position of the scan. However the fourier transform technique is sensitive to changes in the spectrum during one scan because these changes are interpreted as a contribution to the complete wavelength range.

Depending on the fact that the shape of a single track is changing continuously during the etching process, we study the relation between optical density and different values of alpha particles energy and concentrations of etchant solution. The range of α-particles in CR-39 was studied by many authors this work is to make a comparison between three methods which are used in α-range determination.

2. Experimental Procedure

Three group of samples were exposed to alpha particle energies 1, 2, 3, 4 and 5 MeV respectively and then etched in 6N NaOH at (70±1) °C for etching time 11 hrs. Specimens of CR-39 are also irradiated with 500, 1000, 1500 and 2000 rad of gamma rays from ALCYON-II Co-60 teletherapy machine in the Oncology unit of Zagazig...
University Hospitals. The samples of CR-39 irradiated by alpha particles of energies 2, 3, 4 and 5 MeV etched at 6 N NaOH at (70+1) oC for etching time 30 hrs.

Specimens of CR-39 are irradiated with 2 Gy of gamma rays from ALCYON-II Co-60 teletherapy machine in the Oncology unit of Zagazig University Hospitals, also CR-39 recorders are irradiated with X-rays of 85 kilo volt and 200 m.A from X-ray tube DS-TA-5A Toshiba and finally CR-39 detectors are irradiated with α-particles of energy 4 MeV from Am-241, thin source of active diameter 5mm and activity 3.7×108 Bq. The source was covered by 100 Mg/cm2 thin layer gold. Mattson (Unicam) Fourier Transform Infrared (FTIR) spectrometer is used for measuring and scanning the infrared absorption spectra at a resolution of 4cm⁻¹.

2.1. Methods of A-Range Determination

1- By using optical density O.D. of CR-39 irradiated by α-particles is measured by using formula[15] :

\[
O.D. = \log \frac{100}{V} \tag{1}
\]

where V is the reading of millivoltmeter in presence of the sample, which was plotted versus etching time (te) to obtain the time (tpeak) which is the time assumed to remove a layer equal to the range of α-particles in the detector and by which we can calculate the range as following :

\[
R = V_b \cdot t_{\text{peak}} \tag{2}
\]

where \( V_b \) is bulk etch rate .

\[
V_b = \frac{\Delta m}{2 \rho A t} \tag{3}
\]

Where \( \Delta m \) is the mass decrement, \( \rho \) is the detection density, A is area of the surface of detector and t is etching time.

2- By using the overetched track profile technique: α-range determination had been measured at various energies using this method [16].

For \( t_e \gg t_b \), where \( t_e \) is the etching time and \( t_b \) the etching time assumed to remove a thickness equal to range R. It is found that the diameter square \( d^2 \) exhibits linearity with etching time \( t_e \). The range is calculated by using formula:

\[
R = \frac{S}{16V_b} - \frac{I}{S} V_b \tag{4}
\]

where S is the slope of straight line of \( d^2 \) and \( t_e \) relation and I is the intercept of straight line with x-axis .

3- Using the Almasi et al theoretical tables [17]:

In this model, Almasi calculated the range of α-particle theoretically in tables depending on the value of

3. Results and Discussion

Figure (1) shows, IR spectrum of unirradiated CR-39 specimen of thickness 500 µm one notice that, there are four characteristic bands for IR spectroscopy of CR-39, these bands are : OH group characterized is stretching band at wavenumber about 3600 cm⁻¹. the second band is carbonyl group C=O is characterized at wavenumber 1725 cm⁻¹. The last band is C-H stretching band at wavenumber 3000cm⁻¹.

![Fig (1) IR spectrum of unirradiated CR-39](image1)

![Fig (2) IR-Spectrum of CR-39 irradiated with 2000 rad of γ-rays](image2)
Figure (2) shows the unirradiated CR-39 and that is irradiated with 2000 rad of \( \gamma \)-rays. One observed the disappearance of three characteristic bands, C-O group, C=O group and C-H stretching band. For irradiated samples two bands of Co2 are formed, this occur because of the cross linking of the C-O and C=O groups which leads to the recombination of O with CO molecule, at wavenumbers 2300 cm\(^{-1}\) and 660 cm\(^{-1}\) respectively and the O-H group is still noticed at 3600 cm\(^{-1}\).

**Figure (3)** IR-Spectrum of CR-39 irradiated by 85 kv and 200 mA X-ray from X-ray tube

Figure (3) shows the IR-spectrum of CR-39 irradiated with X-rays, is 85k.volt and 200 m.A. from X-ray tube model DS-TA-5A Toshiba. It is clear that, the C-H stretching band is shifted to a wavenumber 3000 cm\(^{-1}\) and a deformation band at 2400 cm\(^{-1}\).

**Figure (4)** IR Spectrum of CR-39 irradiated by 4 MeV \( \alpha \)-particles from Am-241 thin source

IR-spectrum of CR-39 detector irradiated by 4 MeV of \( \alpha \)-particles is shown in figure (4). Two medium bands of C-H group at absorption wavenumbers 3200 and 3400cm\(^{-1}\) were noticed. Also two bands of Co2 are characterized at 2430 and 666 cm\(^{-1}\) was observed.

**Figure (5)** The variation of optical density with the exposure dose of \( \gamma \)-rays

Figure (5) shows the variation of optical density with the exposure \( \gamma \)-rays dose. It is clear that O. D. increases with \( \gamma \)-rays dose and this can be attributed by the increasing of damage caused by different doses of \( \gamma \)-rays on CR-39.
Figure (6) Variation of optical density with etching time for different values of alpha energy

Figure (6) shows the variation of optical density with the etching time for different energies of alpha particles. It is clear that O.D. increases linearly with increasing the etching time (tₑ) until a certain value of time (tₚᵉᵃᵏ) and then it decreased. This decreasing may be explained by track overlapping, noticed. The range of alpha particles was calculated by the product of (tₚᵉᵃᵏ) and Vₑ.

Figure (7) Diameter square (d²) as a function of etching time (tₑ) for alpha energy $E_\alpha = 1$ MeV.

Figure (8) Diameter square (d²) as a function of etching time (tₑ) for alpha energy $E_\alpha = 2$ MeV.

Figure (9) Diameter square (d²) as a function of etching time (tₑ) for alpha energy $E_\alpha = 3$ MeV.

Figure (10) Diameter square (d²) as a function of etching time (tₑ) for alpha energy $E_\alpha = 4$ MeV.

Figure (11) Diameter square (d²) as a function of etching time (tₑ) for alpha energy $E_\alpha = 5$ MeV.
The diameter square ($d^2$) then plotted versus etching time ($t_e$) see figures (7,8,9,10, and 11). We then measured the slope of the linear part and the intercept with the x-axis, and then we can calculate the range of alpha particles from eqn (4).

Table 1 shows the comparison between the range values by using the three methods. It is clear that there is a good agreement between the three methods as shown also in figure (12).

4. Conclusion

FTIR spectroscopy of CR-39 detectors indicate that these detectors are very sensitive to different types of radiation and so this type of detectors can be used as a radiation dosimeter successfully. By using a simple experimental setup, optical density of CR-39 irradiated by alpha-particles of different energies is measured and used in the determination of alpha-range in CR-39. A comparison between this method which is used in this work and two other methods was studied, a agreement between the three methods was observed.

<table>
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<th>$E$</th>
<th>$R_{th} (\mu m)$</th>
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<th>$t_{peak} V_B (\mu m)$</th>
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<td>24.42</td>
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References